0/007904 0/31/01

PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

_	PPL NUM	FILING DATE		SUBCLASS	GAU		EXAMIN	ER					
1	0007904	10/31/2001	324		2958		16r-						
**A	**APPLICANTS: Fetterman H.; Ryan Vivian;												
**CONTINUING DATA VERIFIED:													
1													
								•					
H H H	FOREIGN A	APPLICATIONS V	ERIFIED	:									
d						-		-	-				
7	-								_				
		NOT PUBLISH]		IND 🔲	IATTO	RNEY DO	CKET	NO				
	oreign priority cl S USC 119 cond		-	es⊒no es⊒no			MILI DO						
Ve	erified and Ackr	nowledged Examiners's	intials	1 alb a d db a c	ofor	7-17							
	TLE : Stress	s migration test stru	ucture an	a memod mer		U S DEI	PT, OF COMM /P/	AT.A TM-F	TO-436L	(Rev 12-9			
		·*·			_								

[NOTICE OF ALLO	WANCE MAILED		CLAIMS ALLOWED					
			Assistant Examiner	Total Claims		Print Claim for O.G			
	ISSI	JE FEE		DRAWING					
	Amount Due	Date Paid	1	Sheets Drwg.	Figs.Drwg.	Print Fig.			
			Primary Examiner		<u> </u>	<u> </u>			
	TER	MINAL	PREPARED FOR ISSUE	Application Examiner					
В	EST AVA	DISCLAMER	Were The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.						
			FILED WITH: DISK	(CRF)	in contrat on de	CD-ROM			